Notice of References Cited Application/Control No. 10/538,787 Applicant(s)/Patent Under Reexamination HAUBS ET AL. Examiner Art Unit David K. O'Dell 1609 U.S. PATENT DOCUMENTS Document Number Date Name Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name Davided	Classification
	N	JP 03145485 A	06-1991	Japan	Kondo et al.	
	0	GB 1,172,557	12-1969	Great Britan	Schmidt et. al.	C 07 d 19/00
	Р					
	Q					
	R					
	s					
	T					

NON-PATENT DOCUMENTS

· ·						
*	ļ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Taylor, R.; Krishna, R. Chemical Engineering Science 2000, 55, 5183-5229.				
	٧					
	>					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.